## Notice of References Cited

Application/Control No. 10/710,817	Reexamination	Applicant(s)/Patent Under Reexamination HSU, YI-SHOU		
Examiner	Art Unit			
Quochien B. Vuong	2618	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,806,819	04-1974	Leonard, Didier	455/179.1
*	В	US-4,166,927	09-1979	Hamaoki, Roy T.	455/455
*	c	US-6,011,960	01-2000	Yamada et al.	370/329
*	D	US-6,834,045	12-2004	Lappetelainen et al.	370/329
*	Ε	US-7,206,586	04-2007	Kim et al.	455/450
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

		Document Number	Date			
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NON-PATENT DOCUMENTS		
*	_	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.